



# SHENZHEN LONG JING MICRO-ELECTRONICS CO., LTD.

## DFN1006-3L Plastic-Encapsulate MOSFETS

### LJ1605PT12G

20V P-Channel MOSFET

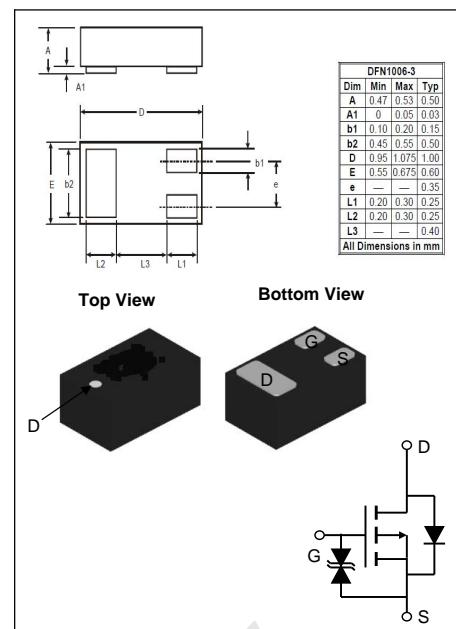
#### General Description

The LJ1605NT12G utilize advanced trench MOSFET technology in small DFN 1.0 x 0.6 package. This device is ideal for load switch applications.

#### Product Summary

$V_{DS}$	-20V
$I_D$ (at $V_{GS}=-4.5V$ )	-0.7A
$R_{DS(ON)}$ (at $V_{GS}=-4.5V$ )	< 650mΩ
$R_{DS(ON)}$ (at $V_{GS}=-2.5V$ )	< 900mΩ
$R_{DS(ON)}$ (at $V_{GS}=-1.8V$ )	< 1000mΩ

#### Typical ESD protection



#### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Maximum	Units
$V_{DS}$	Drain-Source Voltage	-20	V
$V_{GS}$	Gate-Source Voltage	$\pm 8$	V
$I_D$	Continuous Drain Current <sup>E</sup> $T_A=25^\circ\text{C}$	-0.7	A
	$T_A=70^\circ\text{C}$	-0.55	
$I_{DM}$	Pulsed Drain Current <sup>C</sup>	-2	A
$P_D$	$T_A=25^\circ\text{C}$	0.9	W
	$T_A=70^\circ\text{C}$	0.55	
$T_J, T_{STG}$	Junction and Storage Temperature Range	-55 to 150	°C

#### Thermal Characteristics

	Parameter	Typ	Max	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient <sup>A</sup> $t \leq 10\text{s}$	80	100	°C/W
	Maximum Junction-to-Ambient <sup>A</sup> Steady-State	110	140	°C/W
$R_{\theta JA}$	Maximum Junction-to-Ambient <sup>B</sup> $t \leq 10\text{s}$	200	245	°C/W
	Maximum Junction-to-Ambient <sup>B</sup> Steady-State	280	340	°C/W

### Electrical Characteristics ( $T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D=-250\mu\text{A}, V_{GS}=0\text{V}$	-20			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=-20\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$			-1 -5	$\mu\text{A}$
$I_{GSS}$	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 8\text{V}$			$\pm 10$	$\mu\text{A}$
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$	-0.4	-0.65	-1.1	V
$I_{D(\text{ON})}$	On state drain current	$V_{GS}=-4.5\text{V}, V_{DS}=-5\text{V}$	-2			A
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=-4.5\text{V}, I_D=-0.4\text{A}$ $T_J=125^\circ\text{C}$	550	650		$\text{m}\Omega$
		$V_{GS}=-2.5\text{V}, I_D=-0.3\text{A}$	800	950		$\text{m}\Omega$
		$V_{GS}=-1.8\text{V}, I_D=-0.2\text{A}$	700	900		$\text{m}\Omega$
		$V_{GS}=-1.5\text{V}, I_D=-0.1\text{A}$	900	1000		$\text{m}\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS}=-5\text{V}, I_D=-0.4\text{A}$	1015			$\text{s}$
$V_{SD}$	Diode Forward Voltage	$I_S=-0.4\text{A}, V_{GS}=0\text{V}$	1		-0.85	V
$I_S$	Maximum Body-Diode Continuous Current <sup>E</sup>				-1.2	A
					-0.7	A
<b>DYNAMIC PARAMETERS</b>						
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=-10\text{V}, f=1\text{MHz}$		52		pF
$C_{oss}$	Output Capacitance			13		pF
$C_{rss}$	Reverse Transfer Capacitance			8.0		pF
$R_g$	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$		42		$\Omega$
<b>SWITCHING PARAMETERS</b>						
$Q_g$	Total Gate Charge	$V_{GS}=-4.5\text{V}, V_{DS}=-10\text{V}, I_D=-0.4\text{A}$		0.73		nC
$Q_{gs}$	Gate Source Charge			0.13		nC
$Q_{gd}$	Gate Drain Charge			0.1		nC
$t_{D(\text{on})}$	Turn-On DelayTime	$V_{GS}=-4.5\text{V}, V_{DS}=-10\text{V}, R_L=25\Omega, R_{\text{GEN}}=3\Omega$		6		ns
$t_r$	Turn-On Rise Time			4		ns
$t_{D(\text{off})}$	Turn-Off DelayTime			21		ns
$t_f$	Turn-Off Fall Time			9		ns

A: The value of  $R_{\text{QJA}}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{\text{DSM}}$  is based on  $R_{\text{QJA}}$  and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150° C may be used if the PCB allows it to.

B: The value of  $R_{\text{QJA}}$  is measured with the device mounted on FR-4 minimum pad board, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{\text{DSM}}$  is based on  $R_{\text{QJA}}$  and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150° C may be used if the PCB allows it to.

C. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

D. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

E. The maximum current limited by package.

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

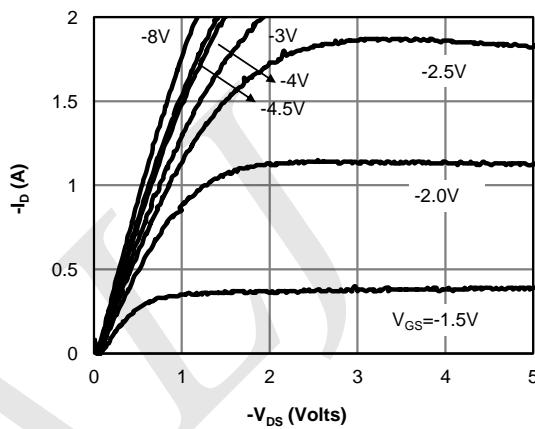


Fig 1: On-Region Characteristics (Note E)

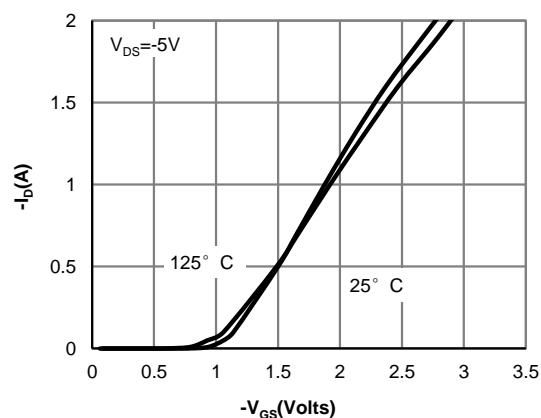


Figure 2: Transfer Characteristics (Note E)

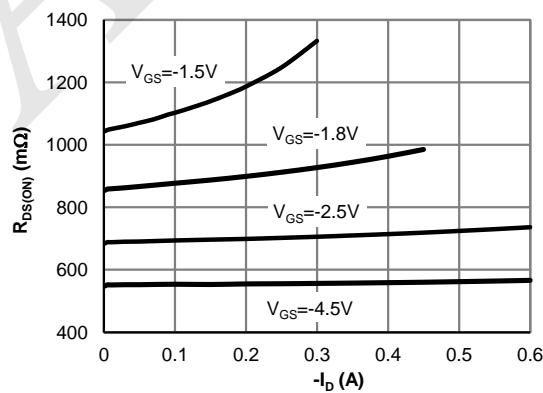


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

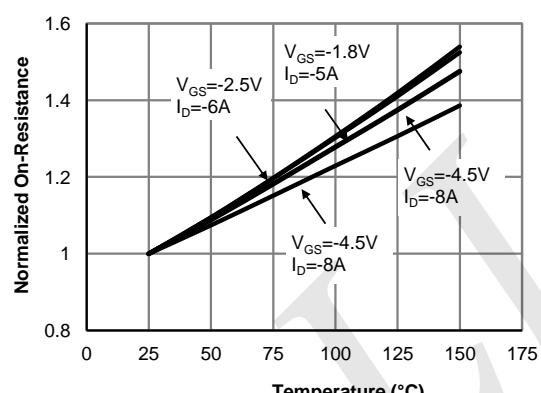


Figure 4: On-Resistance vs. Junction Temperature (Note E)

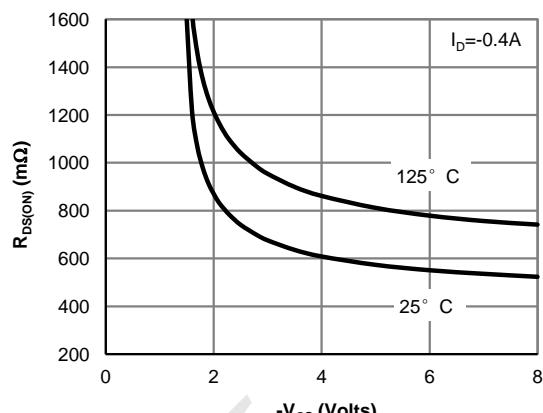


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

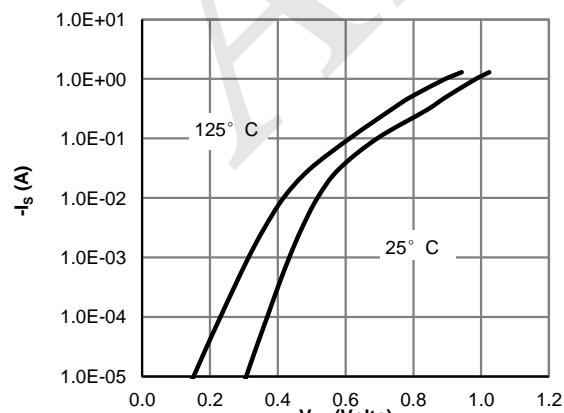


Figure 6: Body-Diode Characteristics (Note E)

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

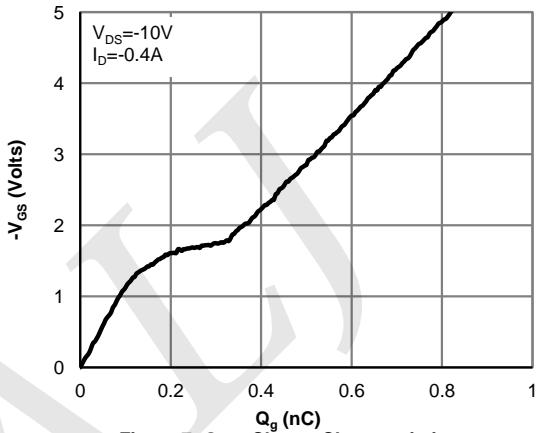


Figure 7: Gate-Charge Characteristics

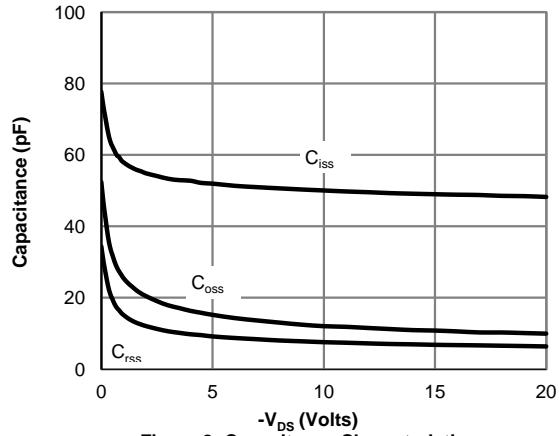


Figure 8: Capacitance Characteristics

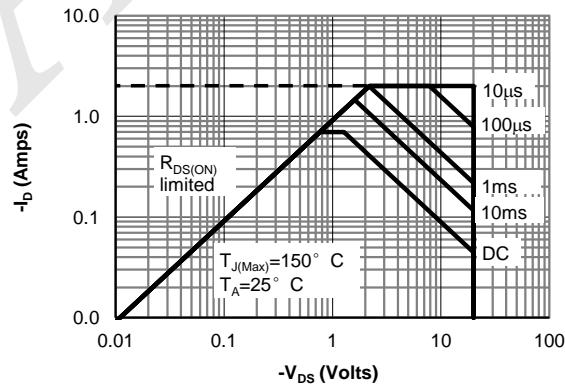


Figure 9: Maximum Forward Biased Safe Operating Area (Note B)

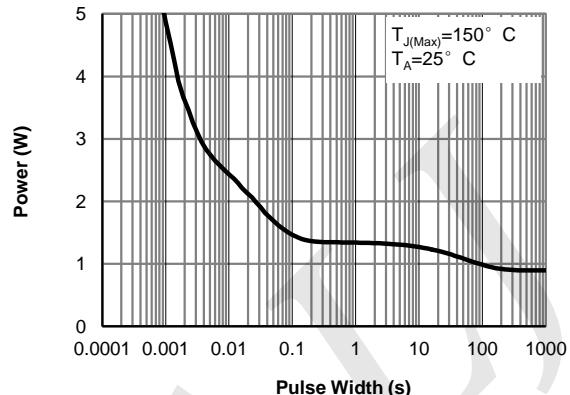


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note B)

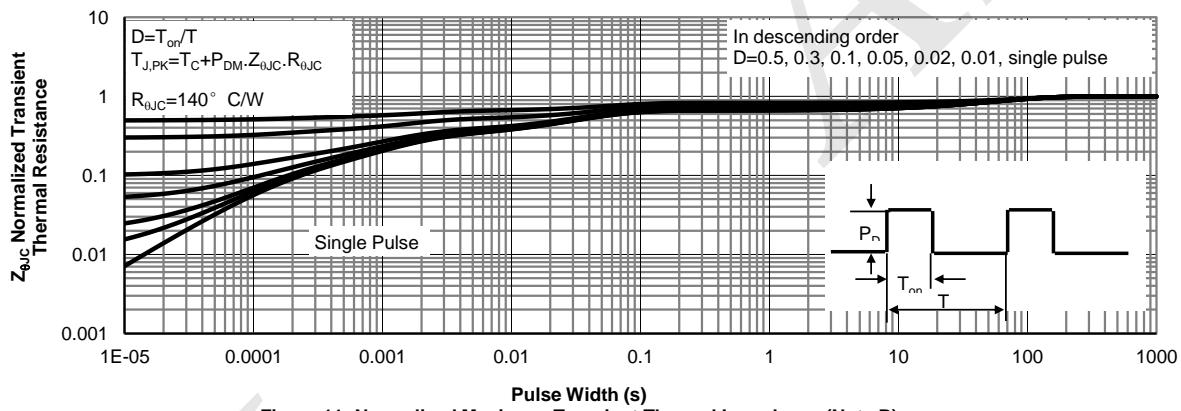
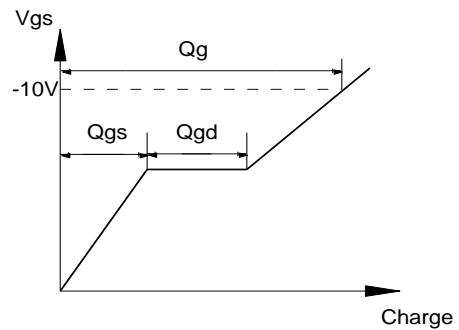
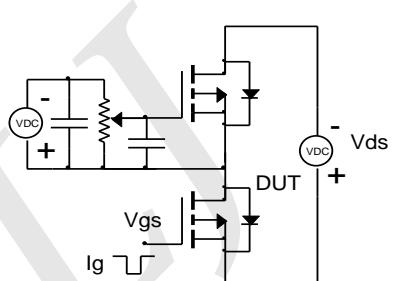
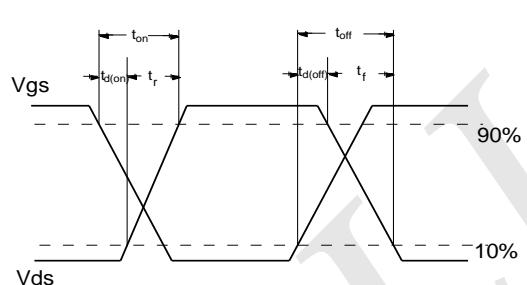
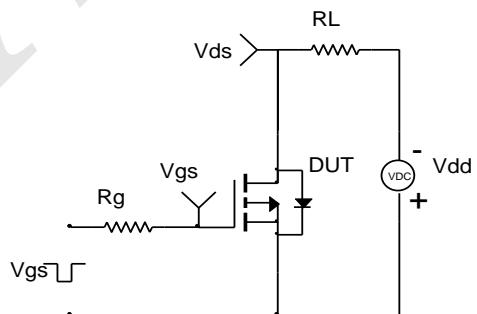


Figure 11: Normalized Maximum Transient Thermal Impedance (Note B)

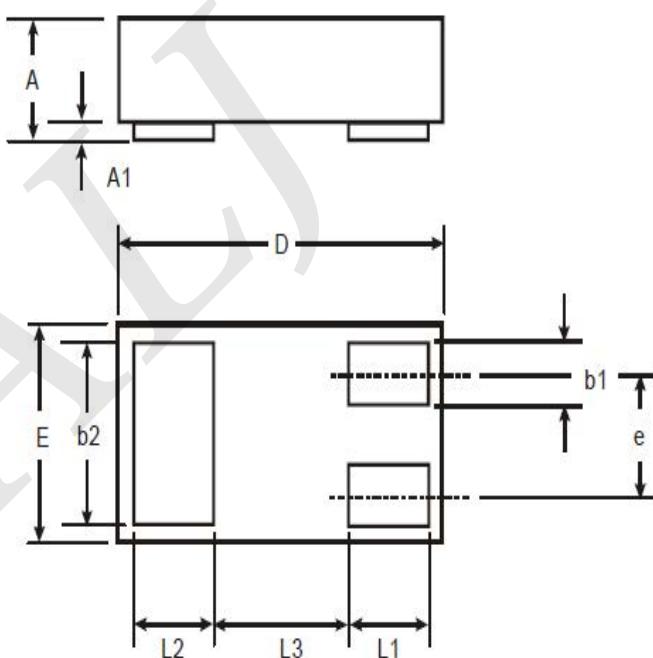
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



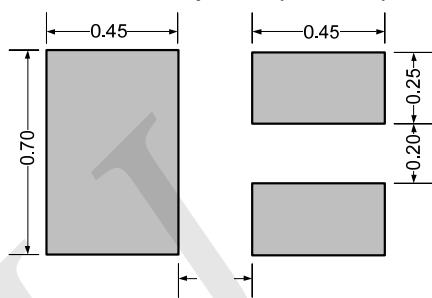
## DFN1006-3L Package Outline Dimensions



DFN1006-3			
Dim	Min	Max	Typ
A	0.47	0.53	0.50
A1	0	0.05	0.03
b1	0.10	0.20	0.15
b2	0.45	0.55	0.50
D	0.95	1.075	1.00
E	0.55	0.675	0.60
e	—	—	0.35
L1	0.20	0.30	0.25
L2	0.20	0.30	0.25
L3	—	—	0.40

All Dimensions in mm

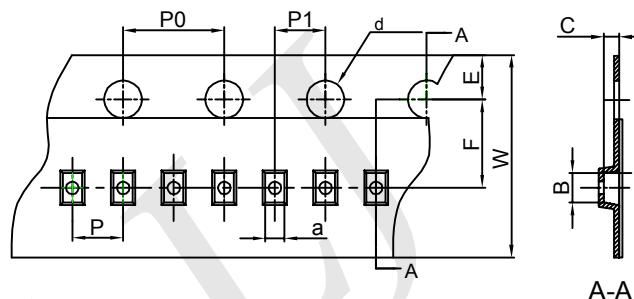
Recommend land pattern (Unit: mm)



Note: This land pattern is for your reference only. Actual pad layouts may vary depending on application.

## DFN1006-3L (1.0×0.6×0.5) Tape and Reel

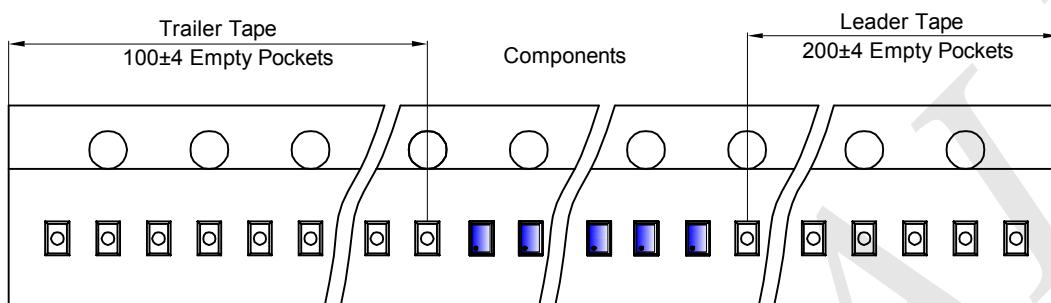
### WFBP-03E(1.0×0.6×0.5) Embossed Carrier Tape



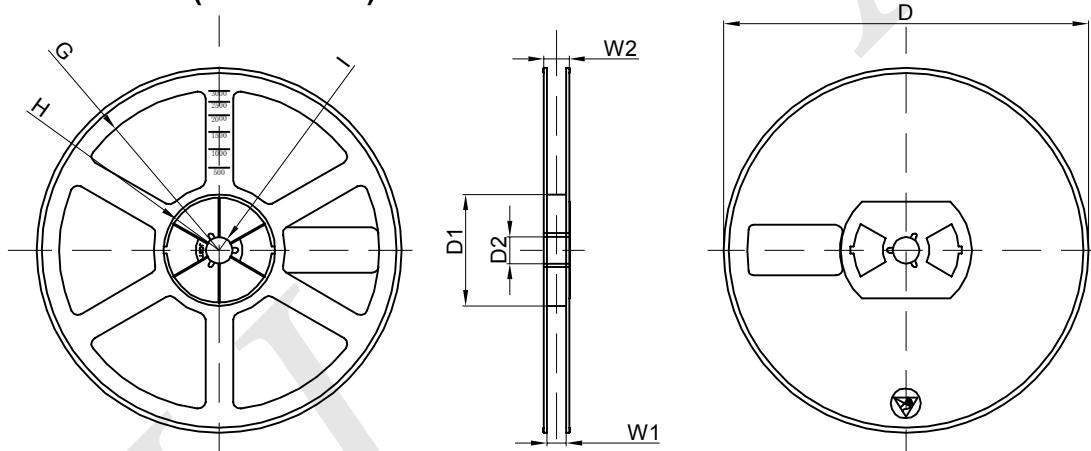
**Packaging Description:**  
DFN1006-3L (1.0×0.6×0.5) parts are shipped in tape. The carrier tape is made from a dissipative (carbon filled) polycarbonate resin. The cover tape is a multilayer film (Heat Activated Adhesive in nature) primarily composed of polyester film, adhesive layer, sealant, and anti-static sprayed agent. These reeled parts in standard option are shipped with 10,000 units per 7" or 17.8cm diameter reel. The reels are clear in color and is made of polystyrene plastic (anti-static coated).

Dimensions are in millimeter										
Pkg type	a	B	C	d	E	F	P0	P	P1	W
WFBP-03E(1.0×0.6×0.5)	0.66	1.15	0.66	Ø1.50	1.75	3.50	4.00	2.00	2.00	8.00

### DFN1006-3L (1.0×0.6×0.5) Tape Leader and Trailer



### DFN1006-3L (1.0×0.6×0.5) Reel



Dimensions are in millimeter							
Reel Option	D	D1	D2	G	H	I	W1
7" Dia	Ø178.00	54.40	13.00	R78.00	R25.60	R6.50	9.50

REEL	Reel Size	Box	Box Size(mm)	Carton	Carton Size(mm)	G.W.(kg)
10000 pcs	7 inch	150,000 pcs	203×203×195	600,000 pcs	438×438×220	

## Soldering Parameters

Reflow Condition		Pb – Free assembly
Pre Heat	Temperature Min ( $T_{s(min)}$ )	150°C
	Temperature Max ( $T_{s(max)}$ )	200°C
	Time (min to max) ( $t_s$ )	60 – 190 secs
Average ramp up rate (Liquidus Temp) ( $T_L$ ) to peak		5°C/second max
		5°C/second max
Reflow	Temperature ( $T_L$ ) (Liquidus)	217°C
	Temperature ( $t_L$ )	60 – 150 seconds
		260+0/-5 °C
Time within actual peak Temperature ( $t_p$ )		20 – 40 seconds
Ramp-down Rate		5°C/second max
Time 25°C to peak Temperature ( $T_P$ )		8 minutes Max.
Do not exceed		280°C

